Electronic structure of the ingredient planes of the cuprate superconductor $\text{Bi}_2\text{Sr}_2\text{CuO}_{6+3}$ **: A** comparison study with $Bi₂Sr₂CaCu₂O_{8+\delta}$

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By means of low-temperature scanning tunneling microscopy, we report on the electronic structures of the BiO and SrO planes of the Bi₂Sr₂CuO_{6+δ} (Bi-2201) superconductor prepared by argon-ion bombardment and annealing. Depending on post annealing conditions, the BiO planes exhibit either a pseudogap (PG) with sharp coherence peaks and an anomalously large gap magnitude of 49 meV or van Hove singularity (vHS) near the Fermi level, while the SrO is always characteristic of a PG-like feature. This contrasts with the $Bi_2Sr_2CaCu_2O_{8+\delta}$ (Bi-2212) superconductor where vHS occurs solely on the SrO plane. We disclose the interstitial oxygen dopants (*δ* in the formulas) as a primary cause for the occurrence of vHS, which are located dominantly around the BiO and SrO planes, respectively, in Bi-2201 and Bi-2212. This is supported by the contrasting structural buckling amplitude of the BiO and SrO planes in the two superconductors. Our findings provide solid evidence for the irrelevance of PG to the superconductivity in the two superconductors, as well as insights into why Bi-2212 can achieve a higher superconducting transition temperature than Bi-2201, and by implication, the mechanism of cuprate superconductivity.

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In high-transition temperature (T_c) cuprate superconductors, the maximum T_c ($T_{c,\text{max}}$) varies substantially with the number (n) of $CuO₂$ planes in one unit cell, and peaks at $n = 3$ [\[1\]](#page-3-0). In the bismuth-based cuprates, for example, $T_{c,max}$ is approximately 34, 90, and 110 K for $n = 1,2,3$, respectively [\[2\]](#page-3-0). It has led to numerous competing proposals to explain this intriguing phenomenon, which include interlayer quantum tunneling of Cooper pairs [\[3–](#page-3-0)[5\]](#page-4-0), intralayer hopping [\[6\]](#page-4-0), the energy level of apical oxygen [\[7\]](#page-4-0), magnetic exchange interactions $[8,9]$, and so on. Thus far, however, a consensus on which factor controls T_c in cuprate superconductors has not yet been reached, partially due to a lack of knowledge about the detailed electronic properties outside the superconducting $CuO₂$ planes, which are antiferromagnetic insulators without doping. Indeed, it has long been hypothesized that out-ofplane apical oxygen plays a primary role in determining the optimal T_c of cuprate superconductors [\[7,10,11\]](#page-4-0). The identification of the out-of-plane effects is thus imperative to understanding $T_{c,max}$ and the superconductivity mechanism in cuprates [\[12\]](#page-4-0), but extremely challenging because technically it demands nonstandard, profile-based preparation and imaging techniques.

Cuprate superconductivity develops when the insulating $CuO₂$ planes are either electron- or hole-doped by substitutional or interstitial chemical doping, e.g., excess oxygen dopants in the hole-doped cuprate superconductors. In addition to enabling superconductivity, the doping can lead to startling nanoscale electronic inhomogeneity and disordering [\[13\]](#page-4-0). The latter is usually detrimental to superconductivity [\[14\]](#page-4-0). However, its effect has been overemphasized over the past two decades $[15-17]$: the experimental efforts in minimizing this secondary effect have demonstrated an enhancement in T_c by only several Kelvins in the bismuthbased cuprate superconductors [\[1](#page-3-0)[,18\]](#page-4-0). In order to understand how the dopants boost superconductivity, scanning tunneling microscopy/spectroscopy (STM/STS) studies have been conducted to visualize the interstitial excess oxygen dopants in the $Bi₂Sr₂CaCu₂O_{8+\delta}$ (Bi-2212) superconductor [\[19–21\]](#page-4-0). However, the central issue of how the excess oxygen dopants affect the electronic structure in the out-of-plane direction and thus that of $CuO₂$ planes remains unknown [\[19–22\]](#page-4-0).

Our recent argon-ion (Ar^+) bombardment and annealing (IBA) approach has enabled a layer-by-layer mapping by STM/STS of the out-of-plane electronic structures in the Bi-2212 cuprate superconductor [\[23\]](#page-4-0), and is particularly suited to addressing the above issues. Here we extend this technique to the Bi₂Sr₂CuO_{6+δ} (Bi-2201) cuprate superconductor, which exhibits a lower $T_{c, max}$ but simpler crystal structure than Bi-2212. Our experiments were carried out in a Unisoku ultrahigh vacuum (UHV) cryogenic STM system with an ozone-assisted molecular beam epitaxy (MBE) chamber, in which an Ar^+ ion gun is installed, as detailed elsewhere [\[23\]](#page-4-0). High quality Pb-doped Bi-2201 single crystals in the extremely overdoped region ($T_c = 4$ K) were synthesized by a traveling solvent floating zone method [\[24\]](#page-4-0), and used throughout. After IBA and post annealing under an ozone flux beam, the Bi-2201 samples were immediately inserted into the STM head for STM/STS measurements at 4.2 K. Polycrystalline PtIr tips were cleaned by *e*-beam heating in UHV and calibrated on MBE-grown Ag/Si(111) films. All STM topographies were acquired in a constant-current mode with a bias *V* applied to

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FIG. 1. (a) Schematic crystal structure of Bi-2201, with the gray parallelogram indicating the easily cleaved BiO planes. The $CuO₆$ octahedra is cyan-colored. (b) STM topography $(100 \text{ nm} \times 100 \text{ nm},$ $V = 1.5$ V, $I = 30$ pA) of the Ar⁺ bombarded and annealed Bi-2201 cuprate superconductor, exposing four constituent planes of BiO(I), SrO(I), BiO(II), and BiO(I'). a and b correspond to the in-plane crystallographic axes (*Cmmm* space group), with $a = b = 5.4$ Å. (c) Zoom-in (6 nm \times 6 nm, $V = 0.1$ V, $I = 30$ pA) on the exposed BiO and SrO planes.

the sample. Tunneling spectra were measured using a standard lock-in technique with a bias modulation of 2 meV at 931 Hz.

Drawn in Fig. $1(a)$ is the crystallographic structure of Bi-2201, which consists of two building blocks (BiO and SrO) other than one superconducting $CuO₂$ plane. The strong hybridization between the p_z orbital of apical oxygen in the two adjacent SrO blocks and the out-of-plane Cu $d_{3r^2-z^2}$ orbital leads to the formation of $CuO₆$ octahedra, analogous to the CuO₅ pyramid in Bi-2212. Figure $1(b)$ depicts a constant-current topographic image of Bi-2201, which has been sputtered by 500 eV Ar⁺ under a pressure of 1×10^{-5} Torr and followed by UHV annealing at 500° C. Four constituent planes of BiO(I), SrO(I), BiO(II), and BiO(I'), defined in Fig. $1(a)$, are discernible. The failure to obtain CuO₂ planes might most probably originate from the fact that $CuO₂$ couples strongly with a pair of SrO layers in Bi-2201, unlike only a SrO layer in Bi-2212 [\[23\]](#page-4-0). A detailed examination reveals an unreconstructed and atomically flat surface on all the exposed planes, as shown in the zoom-in images in Fig. $1(c)$, suggesting that the electronic spectra measured on the exposed planes are characteristic of their bulk counterparts in Bi-2201. Remarkably the incommensurate structural buckling, namely, the *b*-axis supermodulation, appears significantly weaker on the SrO plane than that on BiO, as will be discussed in detail later.

Figure [2](#page-2-0) summarizes the electronic spectra on the varying planes of BiO(I), SrO(I), BiO(II), and BiO(I') in Ar^+ bombarded Bi-2201, followed by UHV annealing to restore the flat surface [Figs. $2(a)-2(d)$], post oxidation annealing under an ozone flux beam of 1*.*0×10−⁵ Torr to add interstitial oxygen [Figs. $2(e) - 2(1)$], and further moderate reduction annealing under UHV condition to remove a small amount of interstitial oxygen dopants [Figs. $2(m)-2(p)$]. The as-sputtered plus UHV annealed samples exhibit *dI/dV* spectra with a substantial depletion in density of states (DOS) near the Fermi level (E_F) on the SrO plane and a pseudogap (PG, or DOS dip)-like feature on BiO [Figs. [2\(a\)–2\(d\)\]](#page-2-0), respectively. Such characteristics, primarily owing to a substantial loss of near-surface interstitial oxygen during IBA, closely resemble those previously reported in Bi-2212 $[23]$. A subsequent oxidation annealing can put the interstitial oxygen dopants back and recover the superconductivity of Bi-2201 studied [Figs. [2\(e\)–2\(p\)\]](#page-2-0), judged by comparing the *dI/dV* spectra of the BiO(I) plane with the "standard" ones of the freshly cleaved superconducting Bi-2201 samples [\[25–28\]](#page-4-0). A closer inspection of these spectra under different annealing conditions has revealed three fundamental findings regarding cuprate superconductors, which we discuss in turn below.

First, a PG occurs not only on the BiO planes in a wide variety of situations [Figs. $2(e)$, $2(g)$, $2(m)$, and $2(o)$], but also on the SrO planes [Figs. $2(f)$ and $2(j)$]. In particular, a comparison of the *dI/dV* spectra in the right two columns of Fig. [2](#page-2-0) reveals a clear PG on BiO(II) [Figs. $2(g)$ and $2(o)$], although the $BiO(I')$ plane beneath with the same chemical identity exhibits a pronounced DOS enhancement near *EF* [Figs. $2(h)$ and $2(p)$]. These observations provide compelling evidence that the PG identified on the as-cleaved Bi-2201 is inherent to the BiO plane, echoing our recent experiment on Bi-2212 [\[23\]](#page-4-0). Additionally, the PG, no matter whether on the BiO or SrO planes, develops only after annealing under an appropriate amount of ozone. In combination with the recent demonstration of a PG in the LaAlO₃/SrTiO₃ interface [\[29\]](#page-4-0) and potassium-doped $Sr₂IrO₄$ with the termination of SrO [\[30,31\]](#page-4-0), we suggest that a PG is inherently a property of electron- or hole-doped metal oxides, but not unique to $CuO₂$, although its key mechanism requires further investigations [\[32–34\]](#page-4-0).

Secondly, the pronounced enhancement in the DOS near E_F , which has been interpreted as a van Hove singularity (vHS, or equivalently DOS peak) [\[23,25\]](#page-4-0), takes place on all the three BiO planes [Figs. $2(h)$, $2(i)$, $2(k)$, $2(l)$, and $2(p)$], while the SrO planes are mainly characteristic of a PG after the two cycles of ozone exposure [Figs. $2(f)$ and $2(i)$]. This contrasts markedly with Bi-2212, in which a vHS is unique to SrO [\[23\]](#page-4-0). Such findings indicate that the vHS or primary charge carrier reservoir, which dopes carriers into the $CuO₂$ layers, might take place on distinct ingredient layers: BiO in Bi-2201 and SrO in Bi-2212, respectively. Considering that a vHS emerges only after an ample amount of ozone exposure, we here argue that it should correlate intimately with the interstitial oxygen dopants.

Lastly and most importantly, the PG observed on the BiO(II) plane [Figs. $2(g)$ and $2(o)$] appears more well defined (substantial accumulation of spectral weight at the two gap edges, or stronger coherence peaks) than those observed on BiO(I) [Figs. $2(i)$ and $2(m)$] or equivalently the BiOterminated surface of as-cleaved Bi-2201 [\[26–28\]](#page-4-0). Because of the unknown nature of PG, the term "coherence peak" does not have any special physical meaning here. Nevertheless, we use this terminology in order for an easy comparison with previous reports. The PG magnitude Δ_p , measured as half the energy separation between the two coherence peaks, are around 24 and 40 meV in Figs. $2(g)$ and $2(0)$, respectively. Both values appear significantly larger than the values of 12–16 meV previously reported in Bi-2201 [\[26–28\]](#page-4-0), which is further confirmed by the line-cut dI/dV spectra with Δ_p ranging from 28 to 49 meV [Fig. $3(a)$]. The well-defined PGs with pronounced coherence peaks and the so-called "dip-hump" structure [Fig. $3(a)$] bear great similarities with those previously measured in the Bi-2212 [\[35\]](#page-4-0) and $Bi_2Sr_2Ca_2Cu_3O_{10+\delta}$ (Bi-2223) cuprate superconductors [\[36\]](#page-4-0). Historically, Δ_p has long been argued

FIG. 2. Representative differential conductance dI/dV spectra on the exposed BiO(I), SrO(I), BiO(II), and BiO(I') constituent planes of the Ar⁺ bombarded Bi-2201 single crystal, followed by a sequence of (a)–(d) UHV annealing at 500 °C, (e)–(h) ozone exposure of 18000 Langmuir, (i)–(l) additional ozone exposure of 18 000 Langmuir, and (m)–(p) UHV annealing at 400 ◦C. The ozone exposure was performed at an optimal sample temperature of 450 ◦C. Black arrows denote the energy positions of the PG. The vHS close to *EF* is found on BiO. Set point: (a)–(l) *V* = 0*.*2 V, *I* = 200 pA; (m), (p) *V* = 0*.*05 V, *I* = 250 pA; (n), (o) *V* = 0*.*1 V, *I* = 250 pA.

0

−90 −60 −30 0 30 60 90 Sample bias (meV)

 0 –90 –60 –30 0 30 60 90

Sample bias (meV)

to correlate closely with the number n of $CuO₂$ planes per unit cell or $T_{c,\text{max}}$: both Δ_p and $T_{c,\text{max}}$ increase proportionally with *n* [\[37\]](#page-4-0). However, our finding of the well-defined PG with a comparatively large Δ_p on the BiO(II) plane in Bi-2201 provides unambiguous evidence that both the Δ_p and PG have little to do with high- T_c superconductivity in cuprate superconductors. An in-depth understanding of why the PG appears so huge and well defined on the BiO(II) plane of Bi-2201 might turn out to be an important key to unveil the mechanism of the PG in cuprates.

 0 -40 -20 0 20 40

Sample bias (meV)

Further insights into the PG and vHS are acquired by a spectroscopic study of the as-cleaved Pb-doped Bi-2201 surface. The spatially universal vHS is immediately visible, as illustrated in Fig. $3(b)$. A subsequent UHV annealing gradually removes the excess interstitial oxygen dopants and then the vHS. Accordingly, the PG develops near E_F and increases in its magnitude Δ_p until the spectrum becomes featureless after a long-term reduction annealing in UHV. This establishes an intimate relationship between the PG/vHS and excess oxygen dopants in cuprate superconductors, consistent with the above argument. As compared to PG, the occurrence of vHS requires more interstitial oxygen. In other words, the constituent plane on which the vHS is observable must accommodate a greater excess of oxygen dopants or charge carriers, namely, the BiO and SrO planes in Bi-2201 and Bi-2212, respectively.

0

−40 −20 0 20 40 Sample bias (meV)

Now the natural concerns arise as to why the vHS acting as the primary carrier reservoir occurs distinctively in Bi-2201 and Bi-2212, and how this difference correlates with the different $T_{c,max}$ in the two cuprate superconductors. To bring insight into these issues, we examine the incommensurate structural buckling in Bi-2212 [Fig. $4(a)$] and compare with that in Bi-2201 [Fig. $1(c)$], since such a periodic structural distortion has been consistently revealed to correlate with the excess oxygen distribution [\[21,38,39\]](#page-4-0). Generally, a stronger

FIG. 3. (a), (b) Spatially resolved STM tunneling characteristics measured along (a) an 8-nm trace on the BiO(II) plane and (b) a 30-nm trace on the BiO(I)-terminated surface of the as-cleaved Bi-2201, respectively. Black and red triangles denote the dip-hump feature. The spectra have been vertically offset for clarity. (c) UHV reduction annealing dependence of spatially averaged *dI/dV* spectra on the ascleaved BiO(I) plane. The UHV annealing was performed at $500 °C$, with the respective duration indicated. Set point: (a), (b) $V = 0.2$ V, $I = 250$ pA; (c) $V = 0.1$ V, $I = 200$ pA.

structural buckling means easier and more incorporation of the external oxygen dopants. By comparison of Figs. $1(c)$ and $4(a)$, we find that the structural buckling behaves conversely in its amplitude between Bi-2201 and Bi-2212. As mentioned above, for example, the structural buckling of BiO plane is stronger than that of SrO in Bi-2201, whereas the opposite holds true in Bi-2212 [Fig. $4(a)$]. This is more convincingly demonstrated in Fig. $4(b)$, which is based on a statistical analysis of structural buckling amplitude from more than fifty STM topographies. We therefore ascribe the contrasting oxygen or vHS distribution as the different structural buckling in the Bi-2201 and Bi-2212 cuprate superconductors.

Finally we comment on the essential implication of contrasting distribution of the vHS or charge carrier reservoir in the Bi-2201 and Bi-2212 cuprate superconductors. It is worth noting in Fig. $1(a)$ that the BiO planes are located relatively far away from the major $CuO₂$ planes, with SrO planes in between. As a consequence, the doping efficiency by charge carriers in the BiO planes would be substantially lower than that in SrO. Given that the high- T_c superconductivity develops with carrier doping of $CuO₂$ planes as seen in the phase diagram [\[28,37\]](#page-4-0), our finding, that the charge carriers are predominantly located around the BiO and SrO planes in Bi-2201 and Bi-2212, respectively, accounts excellently for why Bi-2212 has a higher $T_{c, max}$ than Bi-2201. Indeed, for pure Bi-2201, *T*c*,*max is generally lower than 20 K, whereas La-substituted Bi-2201 (Bi₂Sr_{2−*x*}La_{*x*}CuO₆₊ $_{\delta}$) exhibits a higher $T_{c,max}$ > 30 K for *x* ∼ 0*.*4 [\[24,40\]](#page-4-0). Based on our explanation above, La^{3+} ions substitute for Sr^{2+} sites, acting as positively charged

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FIG. 4. (a) STM topographies $(V = 0.2 \text{ V}, I = 150 \text{ pA},$ $10 \text{ nm} \times 10 \text{ nm}$) showing the structural buckling of the BiO and SrO planes in Bi-2212. (b) Measured structural buckling amplitude on the BiO (blue down triangles) and SrO (red up triangles) planes of Bi-2201 and Bi-2212, namely, the maximum height difference of plane subtracted STM images. Each triangle is obtained by estimating the structural buckling amplitude from one STM topography, while the heights of the blue- and red-colored bars denote the averaged buckling amplitude for the BiO and SrO planes, respectively. Such measurements contain the atomic corrugation, which should be the same as in Bi-2201 and Bi-2212.

centers, helping attract negatively charged oxygen dopants on the SrO planes of La-substituted Bi-2201. This consequently boosts the superconductivity and leads to higher $T_{c, max}$ there.

Our detailed STM/STS measurements of the out-of-plane electronic structures have revealed a sharply different charge carrier reservoir in the Bi-2201 and Bi-2212 cuprate superconductors. This finding provides a reasonably straightforward explanation why Bi-2212 has a quite higher $T_{c,max}$ than Bi-2201. Moreover, we discover that the PG exhibits pronounced coherence peaks and significantly enhanced Δ_p on the BiO(II) plane of Bi-2201, comparable with those reported in Bi-2212 and Bi-2223. Such observation gives definitive proof that the PG has little to do with superconductivity in the $CuO₂$ planes. In this respect, our study has provided crucial insights into high-*T_c* superconductivity in cuprate superconductors.

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